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CMOS Programmable Ionization Smoke Detector ASIC with Interconnect, Timer Mode and Alarm Memory

Features

- 6 – 12V Operation
- Low Quiescent Current Consumption
- Programmable Standby Sensitivity
- Programmable HUSH Sensitivity
- Programmable Hysteresis
- Programmable Chamber Voltage for Push-to-Test (PTT) and Chamber Test
- Programmable ± 150 mV Low Battery Set Point
- Internal Ionization Chamber Test
- Internal Low Battery Test
- Internal Power-On Reset and Power-up Low Battery Test
- Alarm Memory
- Auto Alarm Locate
- Horn Synchronization
- IO Filter and Charge Dump
- Smart Interconnect
- Interconnect up to 40 Detectors
- $\pm 5\%$ All Internal Oscillator
- 9 Minute or 80 Second Timer for Sensitivity Control
- Temporal or Continuous Horn Pattern
- Guard Outputs for Ion Detector Input
- ± 0.75 pA Detect Input Current
- 10-year End-of-Life Indication

Description

The RE46C180 is a next generation low power, CMOS ionization-type, smoke detector IC. With minimal external components, this circuit will provide all the required features for an ionization-type smoke detector.

An on-chip oscillator strobes power to the smoke detection circuitry for 5 ms every 10 seconds to keep the standby current to a minimum.

A check for a Low Battery condition is performed every 80s and an ionization chamber test is performed once every 320s when in Standby. The temporal horn pattern complies with the National Fire Protection Association NFPA 72[®] National Fire Alarm and Signaling Code[®] for emergency evacuation signals.

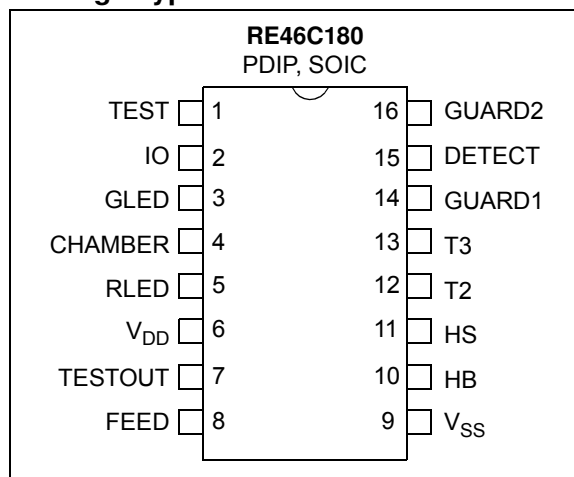
An interconnect pin allows multiple detectors to be connected, such that when one unit alarms, all units will sound. A charge dump feature quickly discharges the interconnect line when exiting a Local Alarm condition. The interconnect input is also digitally filtered.

An internal 9 minute or 80s timer can be used for a Reduced Sensitivity mode.

An alarm memory feature allows the user to determine whether the unit has previously entered a Local Alarm condition.

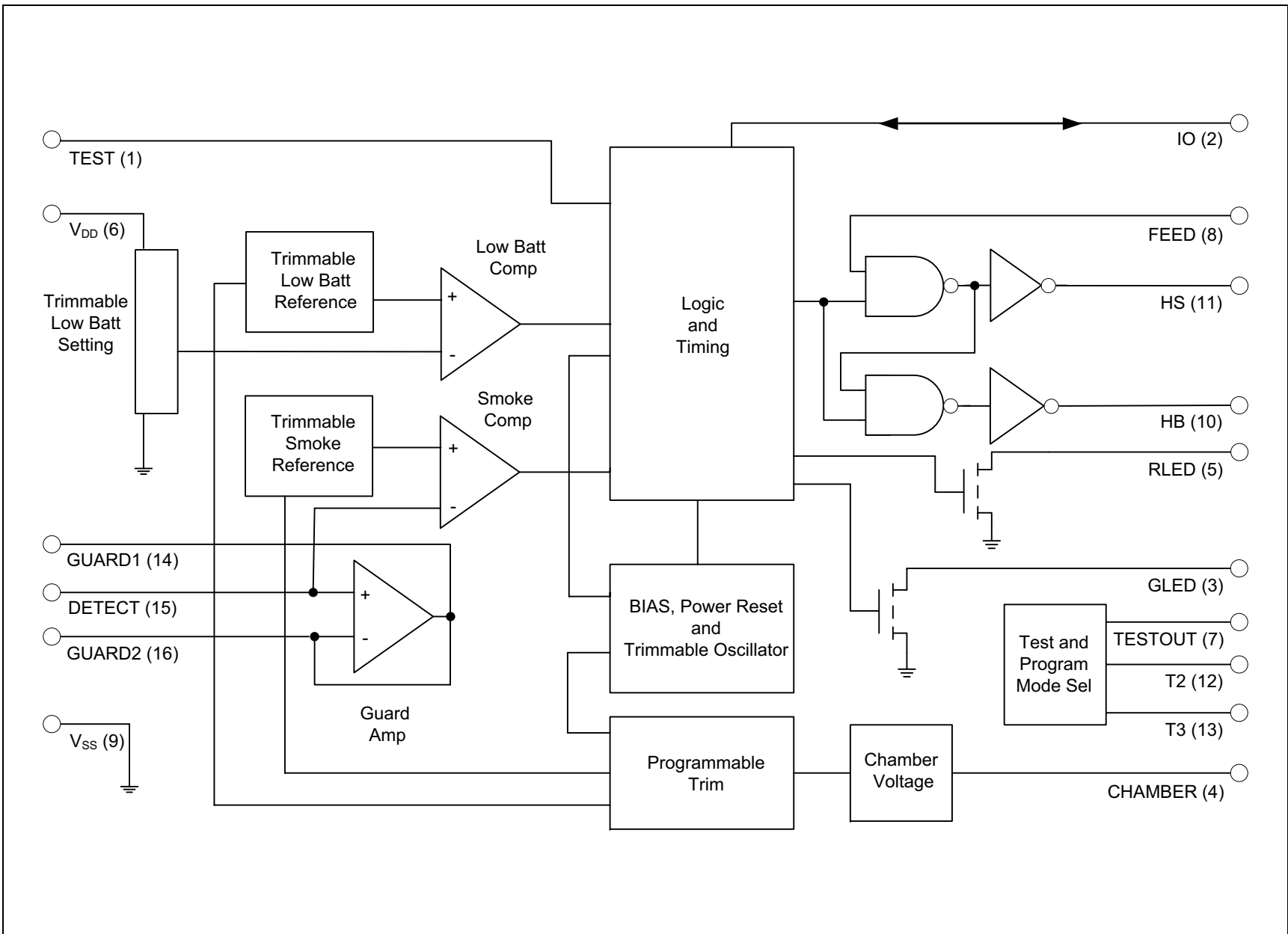
Utilizing low-power CMOS technology, the RE46C180 is designed for use in smoke detectors that comply with the Standard for Single and Multiple Station Smoke Alarms, UL217 and the Standard for Smoke Detectors for Fire Alarm Systems, UL268.

Package Types

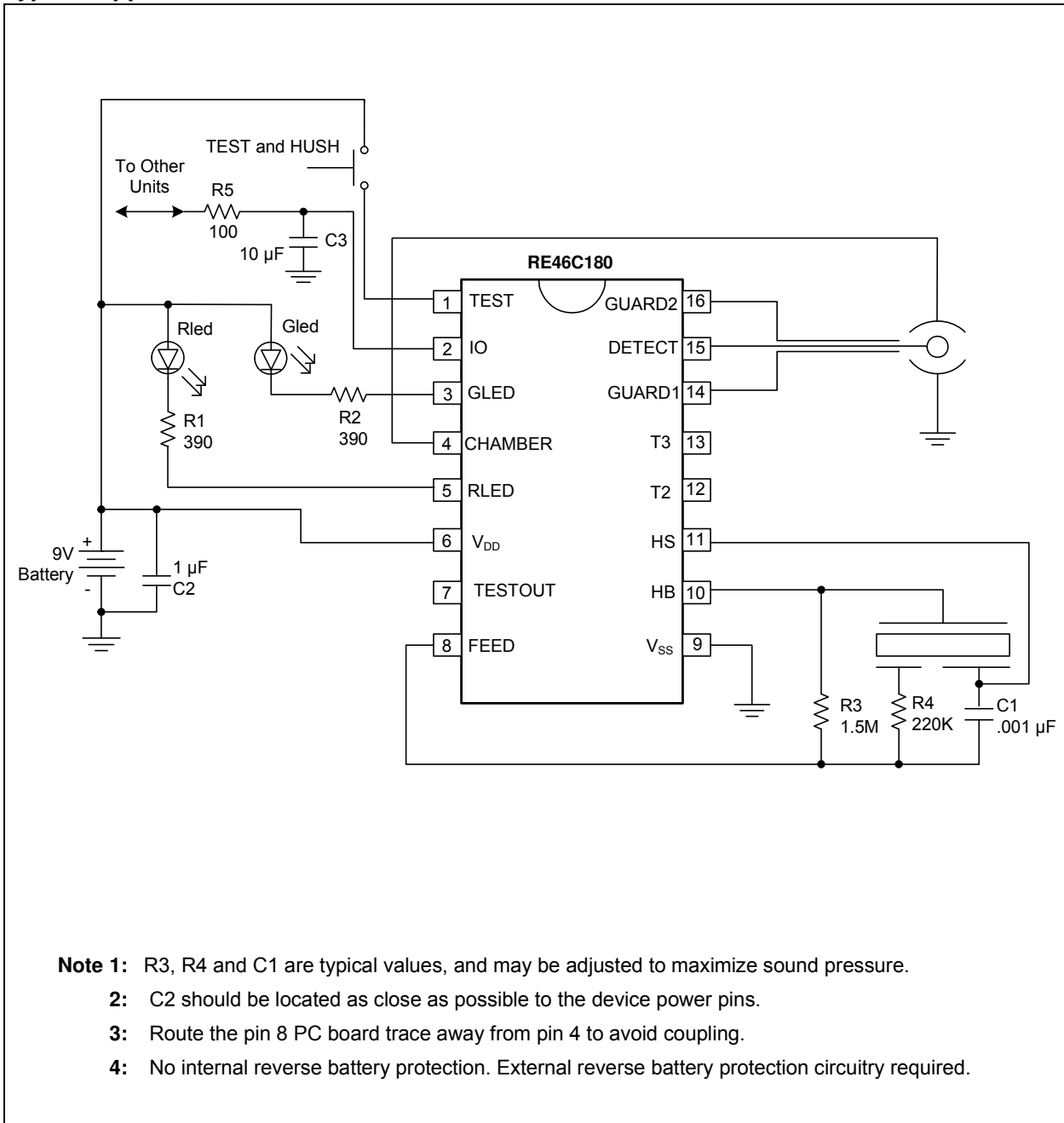


RE46C180

Functional Block Diagram



Typical Application



RE46C180

1.0 ELECTRICAL CHARACTERISTICS

1.1 Absolute Maximum Ratings†

V_{DD}	12.5V
Input Voltage Range Except FEED, IO.....	$V_{IN} = -3V$ to $V_{DD} + 3V$
FEED Input Voltage Range.....	$V_{INFD} = -10$ to $+22V$
IO Input Voltage Range.....	$V_{IO1} = -3$ to $15V$
Input Current except FEED.....	$I_{IN} = 10$ mA
Operating Temperature.....	$T_A = -10$ to $+60^\circ C$
Storage Temperature.....	$T_{STG} = -55$ to $+125^\circ C$
Maximum Junction Temperature.....	$T_J = +150^\circ$

† **Notice:** Stresses above those listed under “Maximum ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

DC Electrical Characteristics: Unless otherwise indicated, all parameters apply at $T_A = -10^\circ C$ to $+60^\circ C$, $V_{DD} = 9V$, $V_{SS} = 0V$ (Note 1)

Parameter	Symbol	Test Pin	Min	Typ	Max	Units	Conditions
Supply Voltage	V_{DD}	6	6	—	12	V	Operating
Supply Current	I_{DD1}	6	—	3.8	5.3	μA	Operating, RLED off, GLED off
	I_{DD2}	6	—	—	6	μA	Operating, $V_{DD} = 12V$, RLED off, GLED off
	I_{DD3}	6	—	9.6	13.9	μA	Operating, RLED off, GLED off, Smoke check
	I_{DD4}	6	—	21.4	30	μA	Operating, RLED off, GLED off, Low Battery check
Input Voltage High	V_{IH1}	8	6	—	—	V	
	V_{IH2}	2	3	—	—	V	No Local Alarm, IO as an input
	V_{IH3}	1	5.6	—	—	V	
	V_{IH4}	12	5.6	—	—	V	
Input Voltage Low	V_{IL1}	8	—	—	2.8	V	
	V_{IL2}	2	—	—	1	V	No Local Alarm, IO as an input
	V_{IL3}	1	—	—	3.4	V	
	V_{IL4}	12	—	—	3.4	V	
Input Leakage Low	I_{LDET1}	15	—	—	-0.75	pA	$V_{DD} = 9V$, DETECT = V_{SS} , 0-40% RH, $T_A = +25^\circ C$
	I_{LDET2}	15	—	—	-1.5	pA	$V_{DD} = 9V$, DETECT = V_{SS} , 85% RH, $T_A = +25^\circ C$ (Note 2)
	I_{LFD1}	8	—	—	-50	μA	FEED = -10V
	I_{LFD2}	8	—	—	-100	nA	FEED = V_{SS}

Note 1: Production tested at room temperature with temperature guard banded limits.

2: Sample test only.

3: Not 100% production tested.

4: Same limit range at each programmable step, see [Table 4-1](#).

DC ELECTRICAL CHARACTERISTICS (CONTINUED)

DC Electrical Characteristics: Unless otherwise indicated, all parameters apply at $T_A = -10^{\circ}\text{C}$ to $+60^{\circ}\text{C}$, $V_{DD} = 9\text{V}$, $V_{SS} = 0\text{V}$ (Note 1)

Parameter	Symbol	Test Pin	Min	Typ	Max	Units	Conditions
Input Leakage High	$I_{H_{DET1}}$	15	—	—	0.75	μA	$V_{DD} = 9\text{V}$, $\text{DETECT} = V_{DD}$, 0–40% RH, $T_A = +25^{\circ}\text{C}$
	$I_{H_{DET2}}$	15	—	—	1.5	μA	$V_{DD} = 9\text{V}$, $\text{DETECT} = V_{DD}$, 85% RH, $T_A = +25^{\circ}\text{C}$ (Note 2)
	$I_{H_{FD1}}$	8	—	—	50	μA	FEED = 22V
	$I_{H_{FD2}}$	8	—	—	100	nA	FEED = V_{DD}
	I_{IOL2}	2	—	—	150	μA	No Alarm, $V_{IO} = 15\text{V}$
Output Off Leakage High	I_{IOHZ}	3, 5	—	—	1	μA	Outputs Off, $V_{RLED} = 9\text{V}$, $V_{GLED} = 9\text{V}$
Input Pull Down Current	I_{PD1}	1	20	50	80	μA	TEST = 9V
	I_{PD2}	12	0.4	0.8	1.3	mA	T2 = 9V
Output High Voltage	V_{OH1}	10,11	6.3	—	—	V	$I_{OH} = -16\text{ mA}$, $V_{DD} = 7.2\text{V}$
Output Low Voltage	V_{OL1}	10,11	—	—	0.9	V	$I_{OL} = 16\text{ mA}$, $V_{DD} = 7.2\text{V}$
	V_{OL3}	3, 5	—	—	1	V	$I_{OL} = 10\text{ mA}$, $V_{DD} = 7.2\text{V}$
Output Current	I_{IOL1}	2	25	—	60	μA	No Alarm, $V_{IO} = V_{DD} - 2\text{V}$
	I_{IOH1}	2	-4	—	-16	mA	Alarm, $V_{IO} = 4\text{V}$ or $V_{IO} = 0\text{V}$
	I_{IODMP}	2	5	—	—	mA	At conclusion of Local Alarm or PTT, $V_{IO} = 1\text{V}$
Low Battery Voltage	V_{LB}	6	6.75	6.9	7.05	V	LBTR[2:1] = 1 0
			7.05	7.2	7.35	V	LBTR[2:1] = 1 1
			7.35	7.5	7.65	V	LBTR[2:1] = 0 0
			7.65	7.8	7.95	V	LBTR[2:1] = 0 1
Offset Voltage	V_{GOS1}	14,15	-50	—	50	mV	Guard amplifier
	V_{GOS2}	15,16	-50	—	50	mV	Guard amplifier
	V_{GOS3}	15	-50	—	50	mV	Smoke comparator
Common Mode Voltage	V_{CM1}	14,15	2	—	$V_{DD} - .5$	V	Guard amplifier (Note 3)
	V_{CM2}	15	0.5	—	$V_{DD} - 2$	V	Smoke comparator (Note 3)
Output Impedance	Z_{OUT}	14,16	—	10	—	$\text{k}\Omega$	Guard amplifier outputs (Note 3)
Chamber Voltage in PTT/Chamber Test	$V_{CHAMBER}$	4	4.49	4.5	4.51	V	User programmable (2.1V to 6.75V) (Note 4)
Hysteresis	V_{HYS}	13	140	150	160	mV	No Alarm to Alarm condition, user programmable (50 to 225 mV) (Note 4)

- Note 1:** Production tested at room temperature with temperature guard banded limits.
Note 2: Sample test only.
Note 3: Not 100% production tested.
Note 4: Same limit range at each programmable step, see Table 4-1.

RE46C180

AC ELECTRICAL CHARACTERISTICS

AC Electrical Characteristics: Unless otherwise indicated, all parameters apply at $T_A = -10^{\circ}\text{C}$ to $+60^{\circ}\text{C}$, $V_{DD} = 9\text{V}$, $V_{SS} = 0\text{V}$.							
Parameter	Symbol	Test Pin	Min	Typ	Max	Units	Conditions
Time Base							
Internal Oscillator Period	T_{POSC}	7	593	625	657	μs	Test mode (Note 1)
Internal Clock Period	T_{PCLK}		9.5	10	10.5	ms	Operating
RLED Indicator							
On Time	T_{ON1}	5	9.5	10	10.5	ms	Operating
Period	T_{PLED1}	5	304	320	336	s	Standby
	T_{PLED2}	5	0.95	1	1.05	s	Local alarm
	T_{PLED3}	5	9.5	10	10.5	s	HUSH mode, No Local Alarm
GLED Indicator							
Period	T_{PLED4}	3	38	40	42	s	Alarm Memory Indication GLED period, No Alarm, no PTT
	T_{PLED5}	3	237	250	263	ms	Alarm Memory Indication GLED period upon PTT, $\text{AMLEDEn} = 1$
Off Time	T_{OFLED1}	3	0.95	1	1.05	s	Alarm Memory Indication GLED off time between pulses
	T_{OFLED2}	3	36	38	40	s	Alarm Memory Indication GLED off time between pulse trains (3x)
Alarm Memory Indication Timeout Period	T_{AMTO}	3	22.8	24	25.2	Hour	$\text{AMTO}[2:1] = 0\ 0$
			45.6	48	50.4	Hour	$\text{AMTO}[2:1] = 0\ 1$
			0	0	0	Hour	$\text{AMTO}[2:1] = 1\ 0$, No Alarm Memory Indication
			—	—	—	—	$\text{AMTO}[2:1] = 1\ 1$, Alarm Memory Indication never times out, as long as Alarm Memory Latch is set
Smoke Check							
Smoke Check Time	T_{SCT}	—	4.7	5	5.3	ms	Operating
Smoke Check Period	T_{PER0}	—	9.5	10	10.5	s	Standby, No Alarm
	T_{PER1}	—	0.95	1	1.05	s	Standby, after one valid smoke sample and before entering Local Alarm, no PTT
	T_{PER2}	—	237	250	263	ms	Standby, upon start of PTT and before entering Local Alarm
	T_{PER3}	—	0.95	1	1.05	s	Local Alarm (after three con- secutive valid smoke samples) or Remote Alarm
Chamber Test Period	T_{PCT1}	—	304	320	336	s	Operating

Note 1: T_{POSC} is 100% production tested. All other timing is verified by functional testing.

Note 2: See timing diagram for CO alarm horn pattern.

Note 3: See timing diagram for smoke alarm temporal and non-temporal horn pattern.

Note 4: See timing diagram for horn synchronization and Auto Alarm Locate (AAL).

AC ELECTRICAL CHARACTERISTICS (CONTINUED)

AC Electrical Characteristics: Unless otherwise indicated, all parameters apply at $T_A = -10^{\circ}\text{C}$ to $+60^{\circ}\text{C}$, $V_{DD} = 9\text{V}$, $V_{SS} = 0\text{V}$.							
Parameter	Symbol	Test Pin	Min	Typ	Max	Units	Conditions
Low Battery							
Low Battery Check Period	T_{PLB1}	—	76	80	84	s	Standby, No Alarm, No Low Battery
	T_{PLB2}	—	304	320	336	s	Standby, No Alarm, Low Battery
Horn Operation							
Horn Delay	T_{HDLY1}	10, 11	475	500	525	ms	From Local Alarm to Horn Active, temporal horn pattern
	T_{HDLY2}	10, 11	380	400	420	ms	From Local Alarm to Horn Active, continuous horn pattern
Horn Period	T_{HPER1}	10, 11	38	40	42	s	Low Battery, No Alarm
	T_{HPER2}	10, 11	38	40	42	s	Chamber Failure, No Alarm
	T_{HPER3}	10, 11	237	250	263	ms	Alarm Memory Indication upon PTT, AMHCEn=1
	T_{HPER4}	10, 11	5.5	5.8	6.1	s	CO Alarm horn period (Note 2)
Horn On Time	T_{HON1}	10, 11	9.5	10	10.5	ms	1. Low Battery, No Alarm 2. Chamber Failure 3. Alarm Memory Indication upon PTT, AMHCEn = 1
	T_{HON2}	10, 11	475	500	525	ms	Smoke Alarm, temporal horn pattern (Note 3)
	T_{HON3}	10, 11	332	350	368	ms	Smoke Alarm, continuous horn pattern (Note 3)
	T_{HON4}	10, 11	95	100	105	ms	CO Alarm, COEn = 1
Horn Off Time	T_{HOF1}	10, 11	475	500	525	ms	Smoke Alarm, temporal horn pattern (Note 3)
	T_{HOF2}	10, 11	1.43	1.5	1.58	s	Smoke Alarm, temporal horn pattern (Note 3)
	T_{HOF3}	10, 11	143	150	158	ms	Smoke Alarm, continuous horn pattern (Note 3)
	T_{HOF4}	10, 11	37	39	41	s	Chamber Fail horn off time between pulse trains (3x)
	T_{HOF5}	10, 11	465	490	515	ms	Chamber Fail horn off time between pulses
	T_{HOF6}	10, 11	95	100	105	ms	CO Alarm horn off time between pulses, COEn = 1 (Note 2)
	T_{HOF7}	10, 11	4.8	5.1	5.4	s	CO alarm horn off time between pulse trains, COEn = 1 (Note 2)

Note 1: T_{POSC} is 100% production tested. All other timing is verified by functional testing.

2: See timing diagram for CO alarm horn pattern.

3: See timing diagram for smoke alarm temporal and non-temporal horn pattern.

4: See timing diagram for horn synchronization and Auto Alarm Locate (AAL).

RE46C180

AC ELECTRICAL CHARACTERISTICS (CONTINUED)

AC Electrical Characteristics: Unless otherwise indicated, all parameters apply at $T_A = -10^{\circ}\text{C}$ to $+60^{\circ}\text{C}$, $V_{DD} = 9\text{V}$, $V_{SS} = 0\text{V}$.							
Parameter	Symbol	Test Pin	Min	Typ	Max	Units	Conditions
Interconnect							
IO Active Delay	T_{IODLY1}	2	3.5	3.7	3.9	s	From start of Local Alarm to IO Active. SyncEn = 1
		2	3.1	3.3	3.5	s	From start of Local Alarm to IO Active. SyncEn = 0
Remote Smoke Alarm Delay	T_{IODLY2}	2	769	810	851	ms	No Local Alarm, from IO Active to Alarm, temporal horn pattern
	T_{IODLY3}	2	299	315	331	ms	No Local Alarm, from IO Active to alarm, continuous horn pattern
IO Filter for Remote Smoke Alarm	T_{IOFILT}	2	—	—	291	ms	IO pulse-width to be filtered IO as input, no Local Alarm
IO Pulse On Time for CO Alarm	T_{IOPW1}	2	37	—	290	ms	No Local Alarm, 2 valid pulses required for CO
IO Pulse Off Time for CO Alarm	T_{IOTO1}	2	—	—	5.4	s	IO = Low
IO Dump	T_{IODMP1}	2	475	500	525	ms	At conclusion of Local Alarm or PTT
Horn Synchronization							
IO Pulse Period	T_{PIO1}	2	3.8	4	4.2	s	Local Alarm, temporal horn pattern, SyncEn = 1 (Note 4)
IO Pulse On Time	T_{ONIO}	2	3.41	3.59	3.77	s	Local Alarm, temporal horn pattern, SyncEn = 1 (Note 4)
Horn Sync IO Dump	T_{IODMP2}	2	95	100	105	ms	Local Alarm, SyncEn = 1 (Note 4)
Horn Sync IO Dump Delay	T_{IODLY4}	2	285	300	315	ms	Local Alarm, SyncEn = 1 (Note 4)
Auto Alarm Locate (AAL)							
IO Cycle Period	T_{PIO2}	2	15.2	16	16.8	s	Local Alarm, temporal horn pattern, SyncEn = 1, NoAAL = 0 (Note 4)
IO Cycle Off Time	T_{OFIO}	2	4.19	4.41	4.63	s	Local Alarm, temporal horn pattern, SyncEn = 1, No AAL = 0, IO off time between IO pulse trains (3x) (Note 4)
HUSH Timer Operation							
HUSH Timer Period	T_{TPER}	—	8.5	9	9.5	min	No Alarm, ShrtTO = 0
		—	76	80	84	s	No Alarm, ShrtTO = 1
EOL							
End-of-Life Age Sample	T_{EOL}	—	346	364	382	Hours	Standby, EOLEn = 1

Note 1: T_{POSC} is 100% production tested. All other timing is verified by functional testing.

2: See timing diagram for CO alarm horn pattern.

3: See timing diagram for smoke alarm temporal and non-temporal horn pattern.

4: See timing diagram for horn synchronization and Auto Alarm Locate (AAL).

TEMPERATURE CHARACTERISTICS

Electrical Specifications: Unless otherwise indicated, $V_{DD} = 9V$, $V_{SS} = 0V$						
Parameters	Sym	Min	Typ	Max	Units	Conditions
Temperature Ranges						
Operating Temperature Range	T_A	-10	—	+60	°C	
Storage Temperature Range	T_{STG}	-55	—	+125	°C	
Thermal Package Resistances						
Thermal Resistance, 16L-PDIP	θ_{JA}	—	70	—	°C/W	
Thermal Resistance, 16L-SOIC (150 mil.)	θ_{JA}	—	86.1	—	°C/W	

RE46C180

2.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in [Table 2-1](#).

TABLE 2-1: PIN FUNCTION TABLE

RE46C180 PDIP, SOIC	Symbol	Function
1	TEST	This input is used to invoke Push-to-Test, Timer mode and Alarm Memory Indication. This input has an internal pull-down.
2	IO	This bidirectional pin provides the capability to interconnect many detectors in a single system. This pin has an internal pull-down device and a charge dump device.
3	GLED	Open drain NMOS output, used to drive a visible LED to provide visual indication of an Alarm Memory condition.
4	CHAMBER	Connect to the ionization smoke chamber. This pin provides power to the chamber
5	RLED	Open drain NMOS output, used to drive a visible LED. This pin provides the load current for the Low Battery test, and is a visual indicator for alarm and HUSH mode.
6	V _{DD}	Connect to the positive supply voltage
7	TESTOUT	This output is an indicator of the internal IO dump signal. This pin is also used for Test modes.
8	FEED	Usually connected to the feedback electrode through a current limiting resistor. If not used, this pin must be connected to V _{DD} or V _{SS} .
9	V _{SS}	Connect to the negative supply voltage.
10	HB	This pin is connected to the metal electrode of a piezoelectric transducer.
11	HS	This pin is a complementary output to HB, connected to the ceramic electrode of the piezoelectric transducer.
12	T2	Test input to invoke Test modes. This pin has an internal pull-down.
13	T3	Test output for Test modes.
14	GUARD1	Output of the guard amplifier. This allows for measurement of the DETECT input without loading the ionization chamber.
15	DETECT	Connect to the CEV of the ionization smoke chamber.
16	GUARD2	Output of the guard amplifier. This allows for measurement of the DETECT input without loading the ionization chamber.

3.0 DEVICE DESCRIPTIONS

3.1 Standby Internal Timing

The internal oscillator is manufactured to $\pm 5\%$ tolerance. The oscillator period, T_{OSC} , is 625 μs . The internal clock period, T_{PCLK} , of 10 ms is derived from the internal oscillator period.

In Standby, once every 10s, the smoke detection circuitry is powered on for 5 ms. At the conclusion of the 5 ms, the status of the smoke comparator is latched. If a Smoke condition is present, the period to the next detection decreases and additional checks are made.

In Standby, once every 80s, the Low Battery detection circuitry is powered on for 10 ms. At the conclusion of the 10 ms, the status of the Low Battery comparator is latched. RLED is enabled for 10 ms every 320s to provide a battery load in the loaded battery test.

In Standby, once every 320s, the chamber test circuitry is powered on for 5 ms. At the conclusion of the 5 ms, the status of the chamber test is latched. See **Section 3.3 “Supervisory Tests”** for details.

3.2 Smoke Detection Circuitry

The collection electrode voltage (CEV) of the ionization chamber is compared to the stored reference voltage at the conclusion of the 5 ms smoke sample period. After the first Smoke condition is detected, the smoke detection rate increases to once every 1s. Three consecutive smoke detections will cause the device to go into Local Alarm, and the horn circuit and IO will be active. RLED will turn on for 10 ms at 1 Hz rate.

In Local Alarm, the smoke reference voltage (smoke sensitivity) is internally increased to provide alarm hysteresis.

There are three separate smoke sensitivity settings (all user programmable):

- Standby sensitivity
- Local alarm (hysteresis) sensitivity
- HUSH sensitivity

During PTT, the standby smoke sensitivity is used in smoke detection; but the CHAMBER voltage is user programmable.

The guard amplifier and outputs are always active, and will be within 50 mV of the DETECT input to reduce surface leakage. The guard outputs also allow for measurement of the DETECT input without loading the ionization chamber.

3.3 Supervisory Tests

Once every 80s, the status of the battery voltage is checked by comparing a fraction of the V_{DD} voltage to an internal reference. In each period of 320s, the battery is checked four times. Of these four battery checks, three are unloaded and one is loaded with RLED enabled, which provides a battery load. Low battery status is latched at the end of the 10 ms RLED pulse.

If the Low Battery test fails, the horn will chirp for 10 ms every 40s, and will continue to chirp until the next loaded Low Battery check is passed. The unloaded Low Battery checks are skipped in Low Battery condition.

As a user programmable option, a Low Battery Hush mode can be selected. If a Low Battery condition exists, upon release of PTT, the unit will enter the Low Battery Hush mode, and the 10 ms horn chirp will be silenced for 8 hours. At the conclusion of the 8 hours the audible indication will resume, if the Low Battery condition still exists

In addition, every 320s, a background chamber test is performed by internally lowering the CHAMBER voltage to a pre-determined level (user programmable) for 3.7s. This will emulate a Smoke condition. At the end of this 3.7s period, the smoke detection circuitry is powered on for 5 ms, and the Smoke condition is detected.

If two consecutive chamber tests failed to detect a simulated Smoke condition, the chamber fail latch is set and the failure warning is generated. The horn will chirp three times every 40s. Each chirp is 10 ms long and three chirps are spaced at a 0.5s interval. The chamber fail warning chirp is separated from the Low Battery warning chirp by about 20s.

The horn will continue this pattern until the chamber fail latch is reset. The chamber fail latch resets when any one of the followings is active:

- Two consecutive chamber tests pass
- Local smoke alarm
- PTT smoke alarm

After the chamber test is completed, the CHAMBER voltage goes back to its normal standby level.

Chamber test is performed approximately 140s after the loaded Low Battery test.

In a Local Alarm, PTT Alarm or Remote Alarm condition, the chamber test is not performed, and the Low Battery chirping is prohibited.

3.4 Push-to-Test (PTT)

PTT is an event when TEST is activated (V_{IH3}). Release of PTT is an event when TEST is deactivated (V_{IL3}). PTT has different functions for different circumstances. In Standby, PTT tests the unit. Upon start of PTT, the CHAMBER voltage is lowered to a pre-determined level (user programmable) to emulate a Smoke condition. The smoke detection rate increases to once every 250 ms. After three consecutive smoke detections, the unit will go into a Local Alarm condition. In alarm, the smoke detection rate decreases to once every 1s. Upon release of PTT, the unit is immediately reset out of Local Alarm, and the horn is silenced. The chamber voltage goes back to the normal standby level, and the detection rate goes back to once every 10s.

When the unit exits a Local Alarm condition, the alarm memory latch is set. PTT will activate the alarm memory indication if the alarm memory latch is set and if the alarm memory indication function has been enabled. If the alarm memory indication function has not been enabled and the alarm memory latch is set, PTT will test the unit as described above. The release of PTT will always reset the alarm memory latch.

In Standby and Low Battery conditions, PTT tests the unit and RLED will be constantly enabled. This allows the user to easily identify the low battery unit without waiting for 40s to hear a horn chirp. Upon release of PTT, RLED goes back to normal standby pulse rate. The Low Battery HUSH mode is then activated, if this function is enabled.

3.5 Interconnect Operation

The bidirectional IO pin allows the interconnection of multiple detectors. In a Local Alarm condition, this pin is driven high 3.7s after a Local Alarm condition is sensed through a constant current source. Shorting this output to ground will not cause excessive current. The IO is ignored as input during a Local Alarm.

The IO also has an NMOS discharge device that is active for 0.5s after the conclusion of any type of Local Alarm. This device helps to quickly discharge any capacitance associated with the interconnect line.

If a remote active high signal is detected, the device goes into Remote Alarm and the horn will be active. RLED will be off, indicating a Remote Alarm condition. Internal protection circuitry allows the signaling unit to have higher supply voltage than the signaled unit, without excessive current draw.

The interconnect input has a 291 ms maximum digital filter. This allows for interconnection to other types of alarms (CO, for example) that may have a pulsed interconnect signal.

As a user-programmable option, the smart interconnect (smart IO) function can be selected. If the IO input is pulsed high twice with a nominal pulse on time

greater than 37 ms and within 5.4s, a CO Alarm condition is detected, and the CO temporal horn pattern will sound. The CO temporal pattern will sound at least two times, if a CO Alarm condition is detected.

3.6 Reduced Sensitivity Mode (HUSH Mode)

Upon release of PTT, the unit may or may not go into a HUSH mode, depending on the user's selection.

If the hush-in-alarm-only option is selected, then only the release of PTT in a Local Alarm condition can initiate a HUSH mode. Upon release of PTT, the unit is immediately reset out of alarm, and the horn is silenced.

If the hush-in-alarm-only option is not selected, then anytime a release of PTT occurs, the HUSH mode is initiated.

In HUSH mode, the smoke sensitivity is lowered to a pre-determined level, which is user programmable. RLED is turned on for 10 ms every 10s.

The HUSH mode period is user programmable – it can be either 9 minutes or 80s. After this period times out, the unit goes back to its standby sensitivity.

If the unit is currently in a HUSH mode, then PTT will test the unit with the standby sensitivity. Upon release of PTT, a new HUSH mode will be initiated.

As another user-programmable option, HUSH mode can be terminated earlier by a smart hush function. This function allows the HUSH mode to be canceled by either a high smoke alarm, or a remote smoke alarm. High smoke alarm is the local smoke alarm caused by a smoke level that exceeds the reduced sensitivity level.

3.7 Alarm Memory

Alarm memory is a user-programmable option. If a unit has entered a Local Alarm, when exiting that Local Alarm, the alarm memory latch is set. The GLED can be used to visually identify any unit that had previously been in a Local Alarm condition. The GLED is pulsed on three times every 40s. Each GLED pulse is 10 ms long and 1s spaced from the next pulse. This alarm memory indication period can be 0, 24, 48 hours or no limit, depending on the user's selection.

The user will be able to identify a unit with an active alarm memory anytime by PTT. Upon start of PTT, the alarm memory indication will be activated. Depending on the user's selection, it can be 4 Hz horn chirp, 4 Hz GLED pulse, or both. Upon release of PTT, the alarm memory latch will be reset.

Anytime a release of PTT occurs, the alarm memory latch will be reset. The initial visual GLED indication is not displayed if a Low Battery condition exists.

3.8 End-of-Life (EOL) Indicator

The EOL indicator is a user-programmable function. If the EOL indicator function is enabled, then approximately every 15 days of continuous operation, TEOL, the circuit will read an age count stored in EEPROM, and will increment this age. After 10 years of operation, an audible indication will be given to signal that the unit should be replaced. The EOL indicator is the same as the chamber test failure warning.

3.9 Tone Pattern

The smoke alarm tone pattern can be either a temporal pattern, or a continuous pattern, depending on the user's selection. The temporal horn pattern supports the NFPA 72[®] National Fire Alarm and Signaling Code[®] for emergency evacuation signals. The continuous pattern is a 70% duty cycle continuous pattern.

If a CO alarm is detected through the IO, the unit will sound the CO tone pattern. The CO tone pattern consists of 4 horn beeps in every 5.8s. Each horn beep is 100ms long and separated by 100ms.

3.10 Horn Synchronization

The horn synchronization function is programmable by the user.

In an interconnected system, if one unit goes into Local Alarm, other units will also go into Remote Alarm. The IO line is driven high by the origination local smoke unit, and stays high during the alarm.

If the Horn Synchronization function is enabled, at the end of every temporal horn pattern and when the horn is off, the origination unit will drive IO low, then high again. This periodic IO pulsing high and low will cause the remote smoke units to go into and out of the Remote Alarm repeatedly. Each time a unit goes into a Remote Alarm, its timing is reset. The horn sound of all remote smoke units will be synchronized with the horn sound of the origination unit.

A protection circuit ensures that the unit that goes first into a Local Alarm will be the master unit that conducts the horn synchronization. The units that go later into Local Alarm will not drive the IO line. This prevents bus contention problem.

This function works with the temporal tone pattern only.

3.11 Auto Alarm Locate

Auto Alarm Locate (AAL) is also a user-programmable function. To use AAL, the horn synchronization has to be selected first. The purpose of AAL is to let users quickly find the local alarm units just by listening. The local alarm units will sound the temporal pattern without interruption. The remote alarm units will sound the pattern with interruption. Every four temporal patterns (or 16s), the remote units are kept silenced for one pattern (or 4s).

The originating unit conducts the IO cycling. Every four temporal patterns the IO is driven low for one temporal pattern. In the remaining three temporal patterns, the IO is still pulsing to keep the horn synchronized.

The RLED of the origination unit and other local smoke units will be turned on 10 ms every 1s. The RLED of the remote smoke units will be off.

RE46C180

NOTES:

4.0 USER PROGRAMMING MODES

Tables 4-1 to 4-6 show the parameters for user smoke calibration.

TABLE 4-1: PARAMETRIC PROGRAMMING

Parametric Programming	Range	Resolution
Standby Smoke Sensitivity (V_{STD})	2.9 → 6.0V (Note 1)	100 mV (Note 1)
Hysteresis (V_{HYS})	+50 → +225 mV (Note 2)	25 mV (Note 2)
HUSH Smoke Sensitivity (V_{HSH})	-1600 mV → -100 mV (Note 3)	100 mV (Note 3)
CHAMBER Voltage at PTT/Chamber Test ($V_{CHAMBER}$)	2.10 → 6.75V (Note 4)	150 mV (Note 4)

Note 1: V_{STD} listed is based on $V_{DD} = 9V$. The actual range is $(29/90)V_{DD} \rightarrow (60/90)V_{DD}$, resolution is $V_{DD}/90$.

2: V_{HYS} is a positive offset from V_{STD} . The listed value is based on $V_{DD} = 9V$. The actual range is $+(0.5/90)V_{DD} \rightarrow +(2.25/90)V_{DD}$, resolution is $(0.25/90)V_{DD}$.

3: V_{HSH} is a negative offset from V_{STD} . The listed value is based on $V_{DD} = 9V$. The actual range is $-(16/90)V_{DD} \rightarrow -(1/90)V_{DD}$, resolution is $V_{DD}/90$.

4: $V_{CHAMBER}$ listed value is based on $V_{DD} = 9V$. Actual range is $(21/90)V_{DD} \rightarrow (67.5/90)V_{DD}$, resolution is $(1.5/90)V_{DD}$.

TABLE 4-2: STANDBY SENSITIVITY (V_{STD}) PROGRAMMING CONFIGURATION AT $V_{DD} = 9V$

V_{STD} Register STTR [5:1] Configuration					Values
STTR5	STTR4	STTR3	STTR2	STTR1	V_{STD}
0	0	0	0	0	4.5V
0	0	0	0	1	4.6V
0	0	0	1	0	4.7V
0	0	0	1	1	4.8V
0	0	1	0	0	4.9V
0	0	1	0	1	5.0V
0	0	1	1	0	5.1V
0	0	1	1	1	5.2V
0	1	0	0	0	5.3V
0	1	0	0	1	5.4V
0	1	0	1	0	5.5V
0	1	0	1	1	5.6V
0	1	1	0	0	5.7V
0	1	1	0	1	5.8V
0	1	1	1	0	5.9V
0	1	1	1	1	6.0V
1	0	0	0	0	2.9V
1	0	0	0	1	3.0V
1	0	0	1	0	3.1V
1	0	0	1	1	3.2V
1	0	1	0	0	3.3V
1	0	1	0	1	3.4V
1	0	1	1	0	3.5V
1	0	1	1	1	3.6V
1	1	0	0	0	3.7V
1	1	0	0	1	3.8V
1	1	0	1	0	3.9V
1	1	0	1	1	4.0V
1	1	1	0	0	4.1V
1	1	1	0	1	4.2V
1	1	1	1	0	4.3V
1	1	1	1	1	4.4V

RE46C180

TABLE 4-3: HYSTERESIS (V_{HYS}) PROGRAMMING CONFIGURATION AT $V_{DD} = 9V$

V_{HYS} Register HYTR[3:1] Configuration			Values
HYTR3	HYTR2	HYTR1	V_{HYS}
0	0	0	150 mV
0	0	1	175 mV
0	1	0	200 mV
0	1	1	225 mV
1	0	0	50 mV
1	0	1	75 mV
1	1	0	100 mV
1	1	1	125 mV

TABLE 4-4: HUSH SENSITIVITY (V_{HSH}) PROGRAMMING CONFIGURATION AT $V_{DD} = 9V$

V_{HSH} Register TMTR[4:1] Configuration				Values
TMTR4	TMTR3	TMTR2	TMTR1	V_{HSH}
0	0	0	0	$V_{STD} - 800$ mV
0	0	0	1	$V_{STD} - 700$ mV
0	0	1	0	$V_{STD} - 600$ mV
0	0	1	1	$V_{STD} - 500$ mV
0	1	0	0	$V_{STD} - 400$ mV
0	1	0	1	$V_{STD} - 300$ mV
0	1	1	0	$V_{STD} - 200$ mV
0	1	1	1	$V_{STD} - 100$ mV
1	0	0	0	$V_{STD} - 1600$ mV
1	0	0	1	$V_{STD} - 1500$ mV
1	0	1	0	$V_{STD} - 1400$ mV
1	0	1	1	$V_{STD} - 1300$ mV
1	1	0	0	$V_{STD} - 1200$ mV
1	1	0	1	$V_{STD} - 1100$ mV
1	1	1	0	$V_{STD} - 1000$ mV
1	1	1	1	$V_{STD} - 900$ mV

TABLE 4-5: CHAMBER VOLTAGE ($V_{CHAMBER}$) PROGRAMMING CONFIGURATION AT $V_{DD} = 9V$

$V_{CHAMBER}$ Register PTTR[5:1] Configuration					Values
PTTR5	PTTR4	PTTR3	PTTR2	PTTR1	$V_{CHAMBER}$
0	0	0	0	0	4.50V
0	0	0	0	1	4.65V
0	0	0	1	0	4.80V
0	0	0	1	1	4.95V
0	0	1	0	0	5.10V
0	0	1	0	1	5.25V
0	0	1	1	0	5.40V
0	0	1	1	1	5.55V
0	1	0	0	0	5.70V
0	1	0	0	1	5.85V
0	1	0	1	0	6.00V
0	1	0	1	1	6.15V
0	1	1	0	0	6.30V
0	1	1	0	1	6.45V
0	1	1	1	0	6.60V
0	1	1	1	1	6.75V
1	0	0	0	0	2.10V
1	0	0	0	1	2.25V
1	0	0	1	0	2.40V
1	0	0	1	1	2.55V
1	0	1	0	0	2.70V
1	0	1	0	1	2.85V
1	0	1	1	0	3.00V
1	0	1	1	1	3.15V
1	1	0	0	0	3.30V
1	1	0	0	1	3.45V
1	1	0	1	0	3.60V
1	1	0	1	1	3.75V
1	1	1	0	0	3.90V
1	1	1	0	1	4.05V
1	1	1	1	0	4.20V
1	1	1	1	1	4.35V

TABLE 4-6: FEATURE PROGRAMMING

Features	Options
Low Battery Detection Selection	6.9V 7.2V 7.5V 7.8V
10 Year End-of-Life Indicator	Enable/Disable
Smart IO with CO Alarm Sensing	Enable/Disable
Auto Alarm Locate	Enable/Disable
Horn Synchronization	Enable/Disable
Low Battery Hush	Enable/Disable
Alarm Memory Indicator at PTT: Horn Chirping	Enable/Disable
Alarm Memory Indicator at PTT: GLED Flashing	Enable/Disable
Alarm Memory Indicator at Standby Time Out Period	0/24/48 hr or no limit
Alarm Memory	Enable/Disable
HUSH Time Out Period	9 minutes or 80s
Smart HUSH	Enable/Disable
HUSH In Alarm Only	Enable/Disable
HUSH	Enable/Disable
Tone Select	Temporal or Continuous

4.1 Calibration and Programming Procedures

Sixteen separate programming and Test modes are available for user customization. The T2 input is used to enter these modes and step through them. To enter these modes, after power-up, T2 must be driven to V_{DD} and held at that level. To step through the modes, the TEST input must first be driven to V_{DD} . T2 is then clocked. TEST has to be high when clocking T2. Anytime T2 and TEST are both driven to low, the unit will come out of these modes and go back to the normal operation mode. FEED and IO are re-configured to become Test mode inputs. A T2 clock occurs when it switches from V_{SS} to V_{DD} . The Test mode functions are outlined in the [Table 4-7](#).

TABLE 4-7: TEST MODE FUNCTIONS

Mode	Descriptions	T2 Clock	TEST	T2	FEED	IO	T3	TESTOUT
M0 Note 1	Normal Operation	0	PTT/HUSH	0	FEED	IO	Not Used	IO Dump Note 2
TM0	Speedup Mode	1	PTT/HUSH	V_{DD}	CLK	IO	Not Used	IO Dump Note 2
TM1	Load Timer for Spill	2	EOL Timer Clock	V_{DD}	HUSH/LB HUSH Timer Clock	Alarm Mem Timer Clock	Not Used	Not Used
TM2	User Feature Programming	3	ProgData	V_{DD}	ProgClk	ProgEn	Not Used	Not Used
TM3	Horn Test/LED On; IO High/Low	4	HornEnB Note 3	V_{DD}	IOHi En IO Dump EnB HB/HS En Note 4	LEDEn	Not Used	Not Used
TM4	Standby Sen Set	5	SmkCompEnB T3EnB	V_{DD}	CalClk	ReadReg	V_{SEN}	SmkCompOut Note 5
TM5	Hyst Sen Set	6	SmkCompEnB T3EnB	V_{DD}	CalClk	ReadReg	V_{SEN}	SmkCompOut Note 5

Note 1: After power-up, the unit is in M0, the normal operation mode. When in M0, if T2 is driven to V_{DD} , the unit will enter TM0.

2: In M0 and TM0, the digital output TESTOUT is driven by the internal IO dump signal.

3: In TM3, if TEST = V_{SS} , the horn is turned on. IO is in weak pull-down; If TEST = V_{DD} , the horn is off. FEED controls IO and HB/HS.

4: Valid when TEST = V_{DD} ;

5: SmkCompOut – digital comparator output (high if DETECT < V_{SEN} ; low if DETECT > V_{SEN}).

6: LBCompOut – digital comparator output (high if V_{DD} < LB trip point; low if V_{DD} > LB trip point).

RE46C180

TABLE 4-7: TEST MODE FUNCTIONS (CONTINUED)

Mode	Descriptions	T2 Clock	TEST	T2	FEED	IO	T3	TESTOUT
TM6	HUSH Sen Set	7	SmkCompEnB T3EnB	V _{DD}	CalClk	ReadReg	V _{SEN}	SmkCompOut Note 5
TM7	PTT/Chamber Test Set	8	SmkCompEnB T3EnB	V _{DD}	CalClk	ReadReg	V _{SEN}	SmkCompOut Note 5
TM8	Program Calibration	9	Not Used	V _{DD}	Not Used	ProgEn	Not Used	Not Used
TM9	Not Used	10						
TM10	Serial Read/Write Calibration	11	ProgData	V _{DD}	ProgClk	ProgEn	Not Used	Not Used
TM11	Not Used	12						
TM12	Standby Sen Check	13	SmkCompEnB T3EnB	V _{DD}	Not Used	Not Used	V _{SEN}	SmkCompOut Note 5
TM13	Hyst Sen Check	14	SmkCompEnB T3EnB	V _{DD}	Not Used	Not Used	V _{SEN}	SmkCompOut Note 5
TM14	HUSH Sen Check	15	SmkCompEnB T3EnB	V _{DD}	Not Used	Not Used	V _{SEN}	SmkCompOut Note 5
TM15	PTT/Chamber Test CHAMBER Voltage Check	16	SmkCompEnB T3EnB	V _{DD}	Not Used	Not Used	V _{SEN}	SmkCompOut Note 5
TM16	Not Used	17						
TM17	LB Test	18	Not Used	V _{DD}	Not Used	LB Test En RLED En	Not Used	LBCompOut Note 6
TM18	Serial Read/Write Feature and Calibration	19	ProgData	V _{DD}	ProgClk	ProgEn	Not Used	Serial Out
TM19	User EE Lock Bit	20	LockSetEn	V _{DD}	Not used	ProgEn	Not Used	Lock Out

- Note 1:** After power-up, the unit is in M0, the normal operation mode. When in M0, if T2 is driven to V_{DD}, the unit will enter TM0.
- 2:** In M0 and TM0, the digital output TESTOUT is driven by the internal IO dump signal.
- 3:** In TM3, if TEST = V_{SS}, the horn is turned on. IO is in weak pull-down; If TEST = V_{DD}, the horn is off. FEED controls IO and HB/HS.
- 4:** Valid when TEST = V_{DD};
- 5:** SmkCompOut – digital comparator output (high if DETECT < V_{SEN}; low if DETECT > V_{SEN}).
- 6:** LBCompOut – digital comparator output (high if V_{DD} < LB trip point; low if V_{DD} > LB trip point).

RE46C180

6. Drive TEST from V_{SS} to V_{DD} and hold at V_{DD} . Apply another clock pulse to the T2 input, to enter in TM6 mode. This initiates the calibration mode for the HUSH sensitivity setting. Drive TEST from V_{DD} to V_{SS} to turn on the smoke comparator and enable the T3 switch. The HUSH smoke sensitivity V_{SEN} will appear at T3. The smoke comparator output will appear at TESTOUT. Clock FEED to increase or decrease the V_{SEN} levels as needed. The IO input is pulsed low-to-high to save the result
7. Drive TEST from V_{SS} to V_{DD} and hold at V_{DD} . Apply another clock pulse to the T2 input to enter in TM7 mode. This initiates the calibration mode for the CHAMBER voltage at PTT/Chamber Test. Drive TEST from V_{DD} to V_{SS} to turn on the smoke comparator and enable the T3 switch. The standby smoke sensitivity V_{SEN} will appear at T3. The smoke comparator output will appear at TESTOUT. Clock FEED to increase or decrease the CHAMBER voltages as needed. The IO input is pulsed low-to-high to save the result.
8. After sensitivity settings and CHAMBER voltage calibrations have been made, pulse IO to store all results into memory. Before this step, no settings are stored into memory.

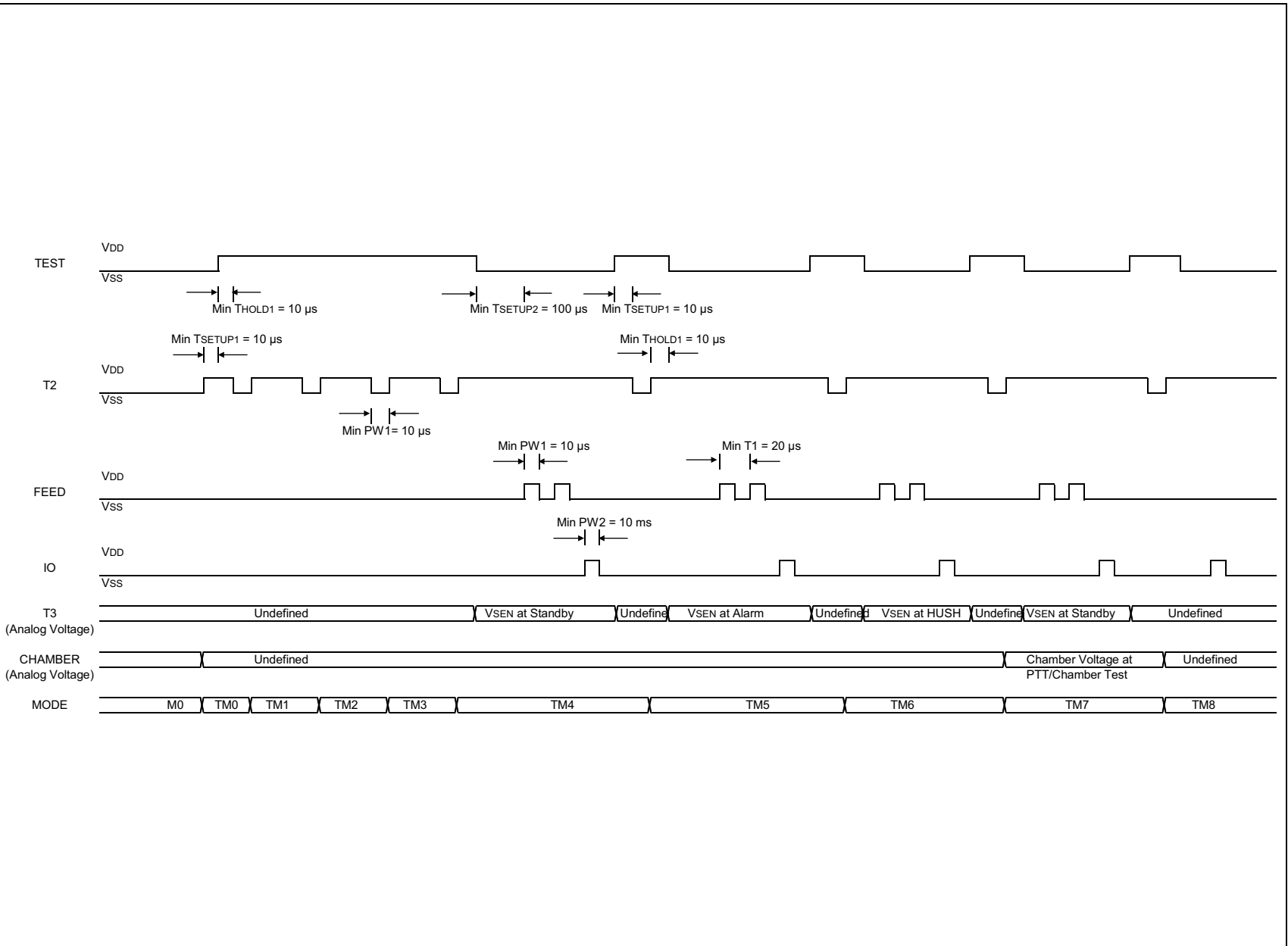


FIGURE 4-2: Timing Diagram for Smoke Calibration (Mode TM4 ~ TM8).

RE46C180

4.3 Serial Read/Write Calibration

As an alternative to the steps in [Section 4.2, Smoke Calibration](#), the sensitivity settings can be entered directly from a Serial Read/Write Calibration mode (if the system has been well characterized).

To enter this mode, follow these steps:

1. Power up with the bias condition shown in [Figure 4-1](#) to enter M0. At power-up:
TEST = IO = FEED = T2 = V_{SS} ,
DETECT = V_{DD} ,
2. Drive T2 input from V_{SS} to V_{DD} and hold at V_{DD} to enter TM0.
3. Drive TEST from V_{SS} to V_{DD} and hold at V_{DD} .
4. Apply 10 clock pulses to the T2 input (V_{DD} to V_{SS} and back to V_{DD}) to enter in TM10 mode. This enables the Serial Read/Write Calibration mode.
5. TEST now acts as a data input (High = V_{DD} , Low = V_{SS}). FEED acts as the clock input (High = V_{DD} , Low = V_{SS}). Clock in the sensitivity settings.

The data sequence should be as follows:

- 5 bit Standby Sensitivity (LSB first)
 - 3 bit Hysteresis (LSB first)
 - 4 bit HUSH Sensitivity (LSB first)
 - 5 bit CHAMBER voltage in PTT/Chamber Test (LSB first)
6. After all 17 bits have been entered, pulse IO to store into the EEPROM memory.

REGISTER 4-1: CALIBRATION CONFIGURATION REGISTER

	W-x
	PTTR5
	bit 17

W-x	W-x	W-x	W-x	W-x	W-x	W-x	W-x
PTTR4	PTTR3	PTTR2	PTTR1	TMTR4	TMTR3	TMTR2	TMTR1
bit 16							bit 8

W-x	W-x	W-x	W-x	W-x	W-x	W-x	W-x
HYTR3	HYTR2	HYTR1	STTR5	STTR4	STTR3	STTR2	STTR1
bit 8							bit 1

Legend:

R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared x = Bit is unknown

bit 17 **PTTR5:** MSB (See [Table 4-5](#))
bit 16 **PTTR4:** 4SB
bit 15 **PTTR3:** 3SB
bit 14 **PTTR2:** 2SB
bit 13 **PTTR1:** LSB
bit 12 **TMTR4:** MSB (See [Table 4-4](#))
bit 11 **TMTR3:** 3SB
bit 10 **TMTR2:** 2SB
bit 9 **TMTR1:** LSB
bit 8 **HYTR3:** MSB (See [Table 4-3](#))
bit 7 **HYTR2:** 2SB
bit 6 **HYTR1:** LSB
bit 5 **STTR5:** MSB (See [Table 4-2](#))
bit 4 **STTR4:** 4SB
bit 3 **STTR3:** 3SB
bit 2 **STTR2:** 2SB
bit 1 **STTR1:** LSB

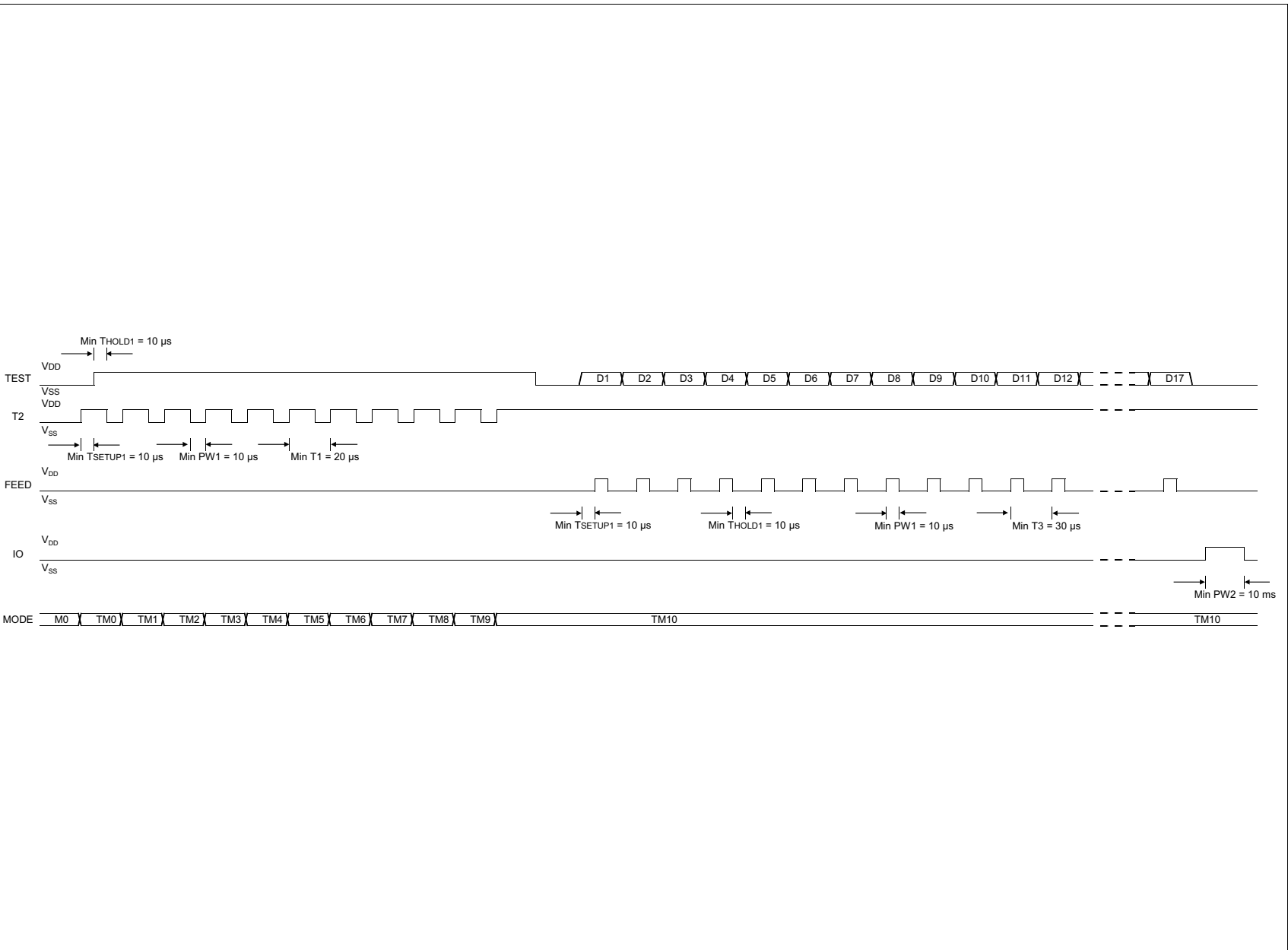


FIGURE 4-3: Timing Diagram for Mode TM10.

4.4 User Feature Selections

User feature selections can be clocked in serially using TEST as data input, and FEED, as a clock input, then stored in the internal EEPROM.

The detailed steps are as follows:

1. Power up with the bias condition shown in [Figure 4-1](#). At power-up:
TEST = IO = FEED = T2 = V_{SS},
DETECT = V_{DD}. Now in mode M0.
2. Drive T2 input from V_{SS} to V_{DD} and hold at V_{DD} to enter TM0.
3. Drive TEST from V_{SS} to V_{DD} and hold at V_{DD}.
4. Apply two clock pulses to the T2 input (V_{DD} to V_{SS} and then back to V_{DD}) to enter in TM2.
5. Using TEST as data and FEED as clock, shift in values of 18 bits as selected from [Register 4-2](#).
6. After shifting in data, pull IO input to V_{DD}, then V_{SS} (minimum pulse-width of 10 ms) to store shift register contents in the memory.
7. If any changes are required, power down the part and return to Step 1. All bit values must be reentered.

REGISTER 4-2: USER FEATURE CONFIGURATION REGISTER

	U	W-x
	—	LBTR2
	bit 18	bit 17

W-x	W-x	W-x	W-x	W-x	W-x	W-x	W-x
LBTR1	EOLEn	COEn	NoAAL	SyncEn	LBHshEn	AMHCEn	AMLEDEn
bit 16							bit 8

W-x	W-x	W-x	W-x	W-x	W-x	W-x	W-x
AMTO2	AMTO1	AMEn	ShrTO	Smrth	HIAO	HushEnB	TSEL
bit 8							bit 1

Legend:

R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared
		x = Bit is unknown

- bit 18 **Unimplemented:** Read as 'x'
- bit 17 **LBTR2:** MSB
- bit 16 **LBTR1:** LSB
 - 00 = 7.5V
 - 01 = 7.8V
 - 10 = 6.9V
 - 11 = 7.2V
- bit 15 **EOLEn:** End-of-Life Indicator Enable Bit
 - 1 = Enable
 - 0 = Disable
- bit 14 **COEn:** CO Alarm Function (Smart IO) Enable Bit
 - 1 = Enable
 - 0 = Disable
- bit 13 **NoAAL:** Auto Alarm Locate Disable Bit
 - 1 = AAL is Disabled
 - 0 = AAL is Enabled
- bit 12 **SyncEn:** Horn Synchronization Enable Bit
 - 1 = Enable
 - 0 = Disable